

# Condensed Matter Physics Laboratory

# Contacts

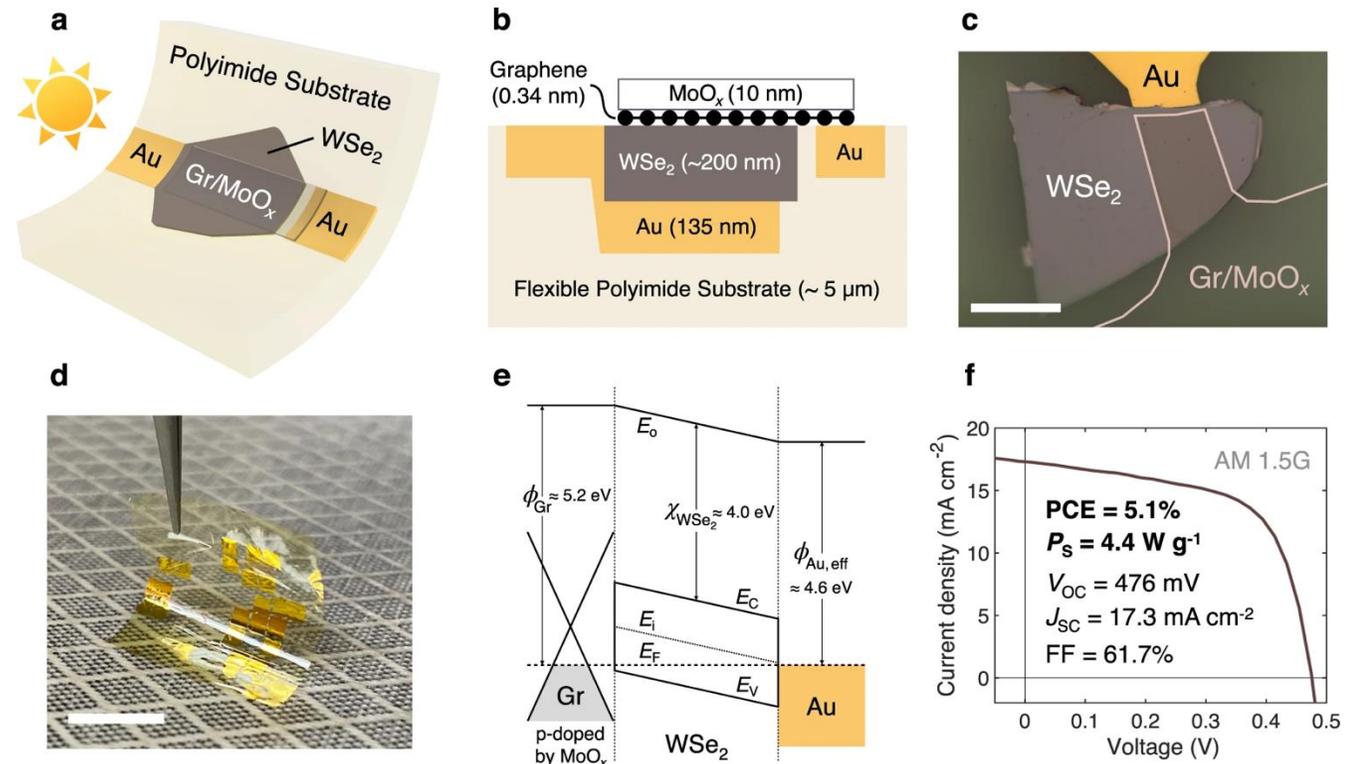
- Alberto Morgante: [amorgante@units.it](mailto:amorgante@units.it)
- Francesco Scazza: [francesco.scazza@units.it](mailto:francesco.scazza@units.it)
- Roberto Costantini: [roberto.costantini@units.it](mailto:roberto.costantini@units.it)
- Matteo Marinelli: [matteo.marinelli@units.it](mailto:matteo.marinelli@units.it)

# Introduction I

The development of new functional materials is linked to the study of their physical (and chemical) properties, to their response to external stimuli, etc.

The characterization of a material allows us to obtain useful information to improve its properties:

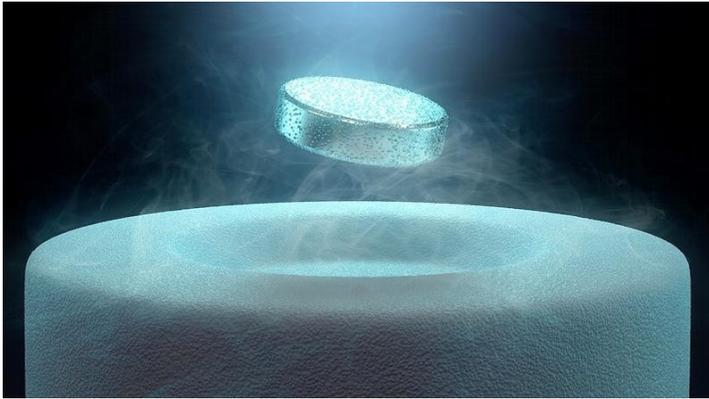
- avoiding oxidation/contamination or performance losses
- improving the synthesis protocols
- finding strategies to tailor the electronic properties on demand...



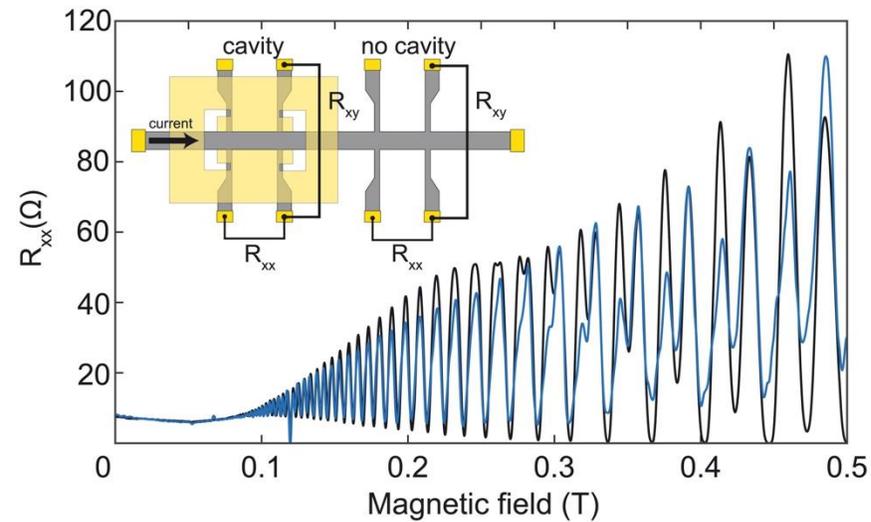
# Introduction II

Some synthetic and/or nanostructured material allow for studying fundamental physical processes, for example:

Superconductivity

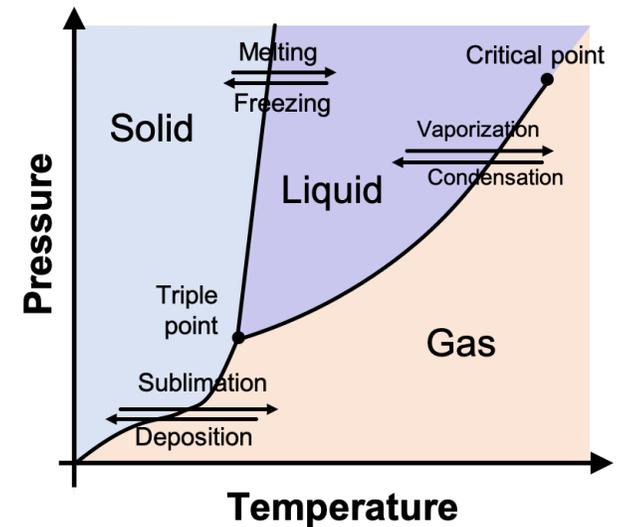


Quantum Hall effect



Appugliese *et al.* *Science* **375**, 1030 (2022)

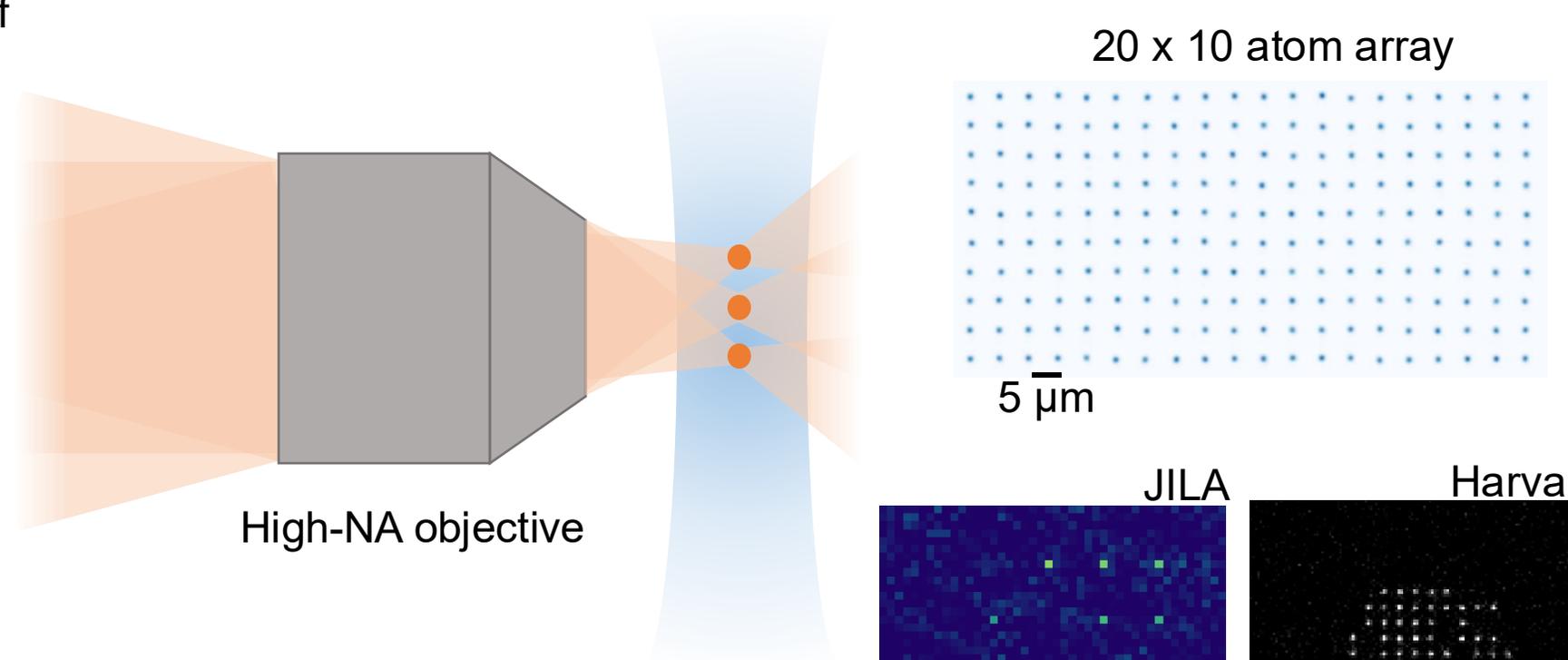
Phase transitions



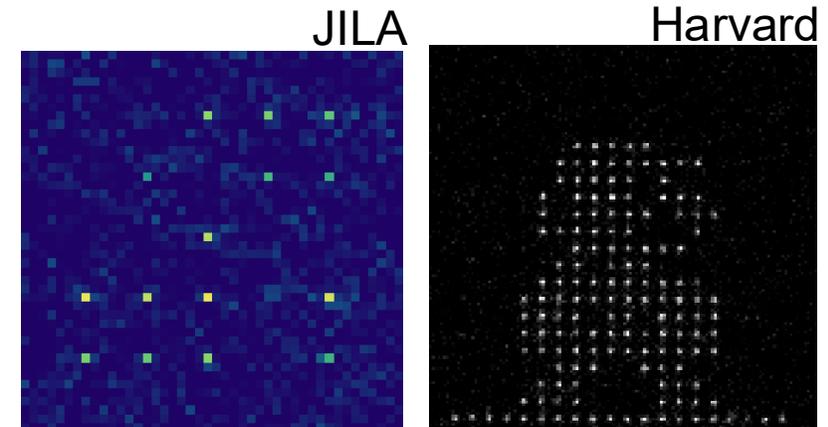
# Introduction III

Atoms are trapped by virtue of light-matter interaction

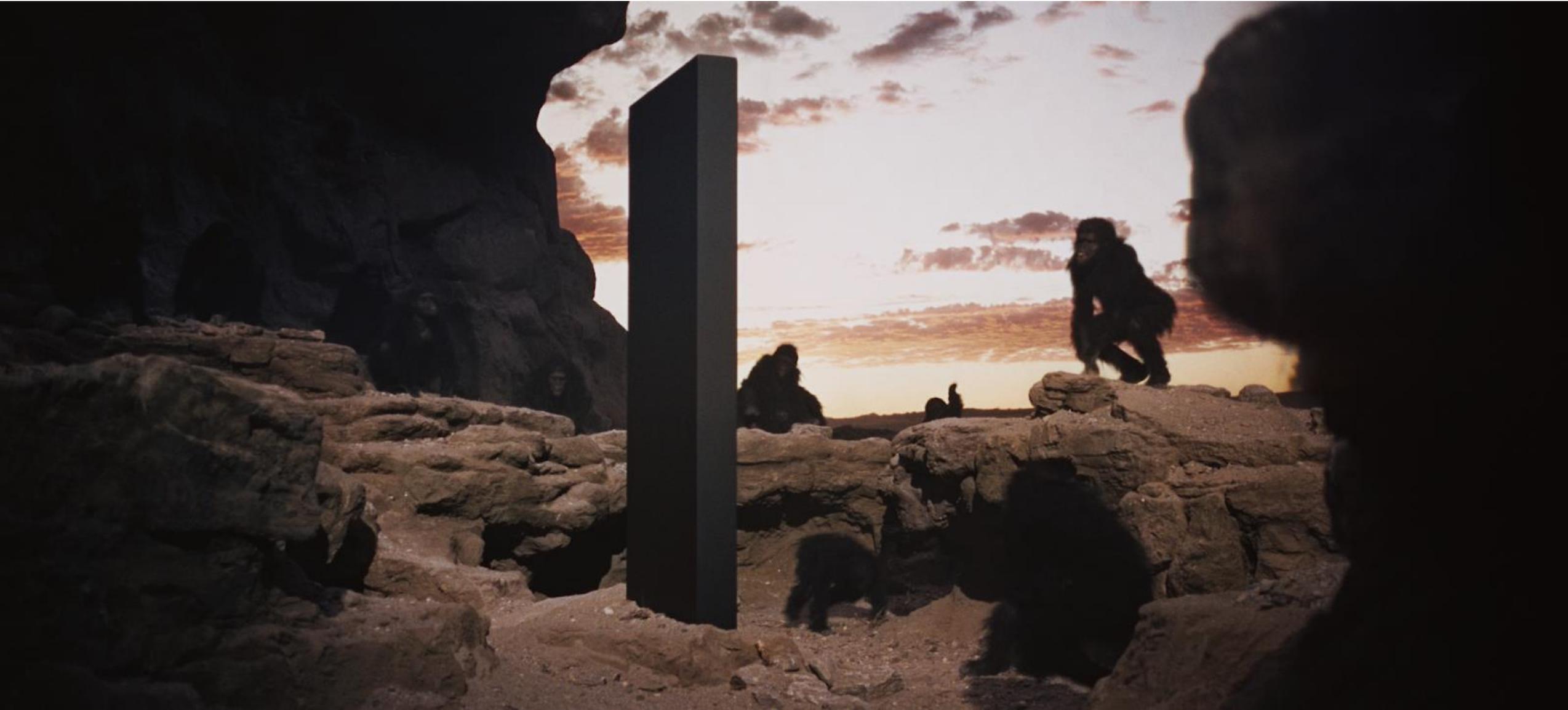
Laser beams are used to manipulate atoms and for fluorescence detection



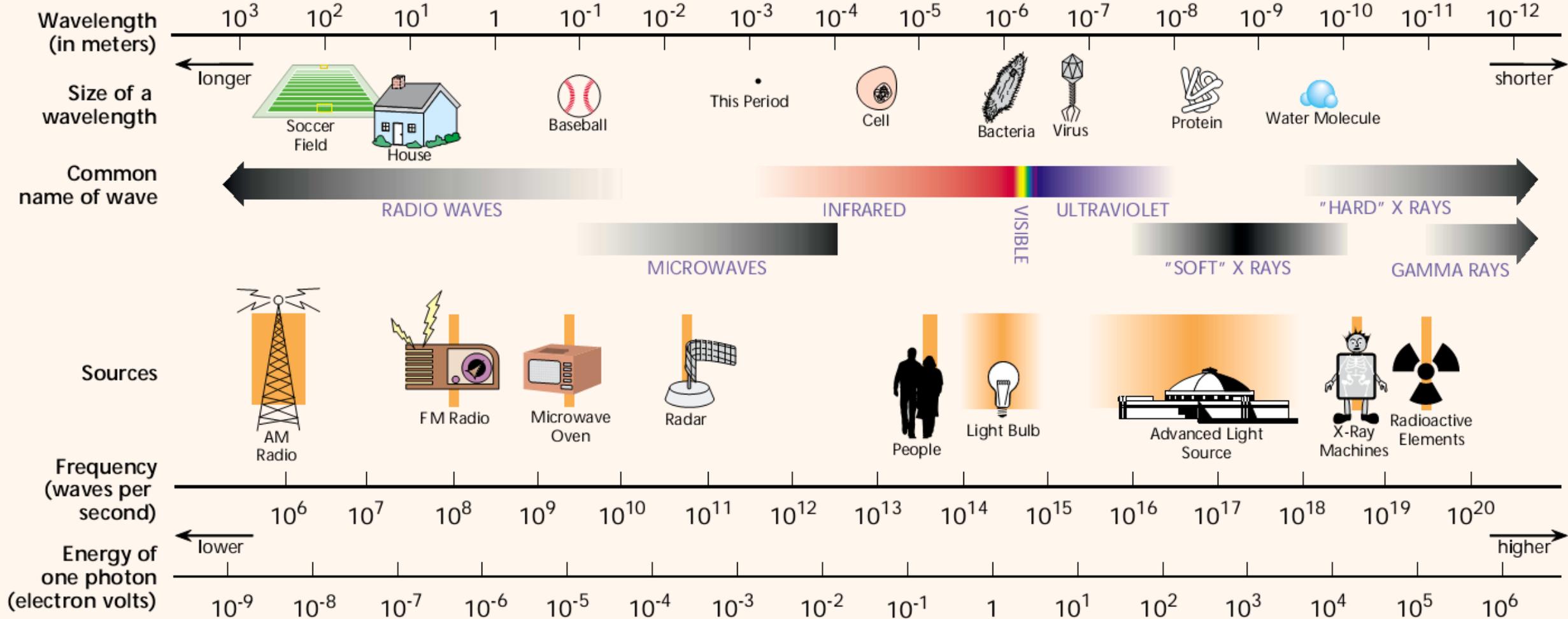
Pioneering technology from Grangier group



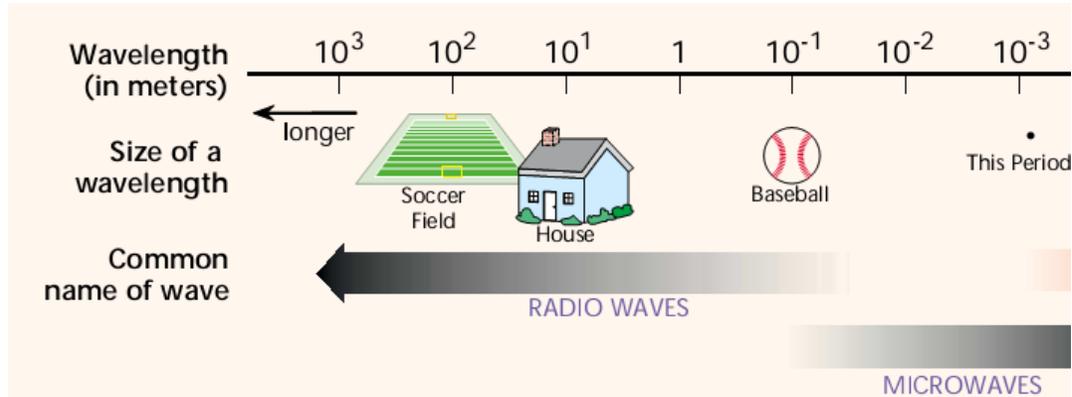
# How do I analyze a material?



# THE ELECTROMAGNETIC SPECTRUM

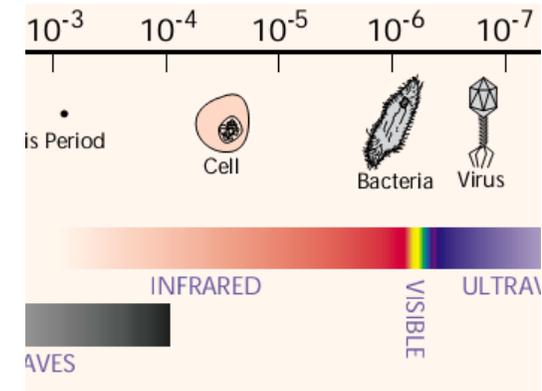


# Physical dimensions



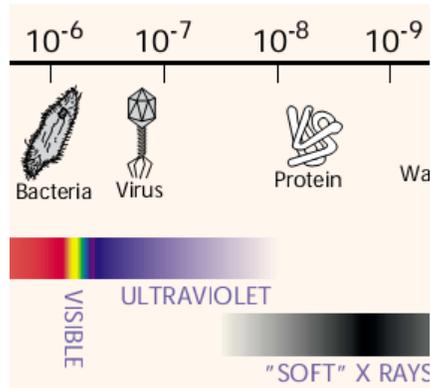
## Macrostructure (>mm)

Topography, composition, macroscopic properties (temperature, conductivity,...)



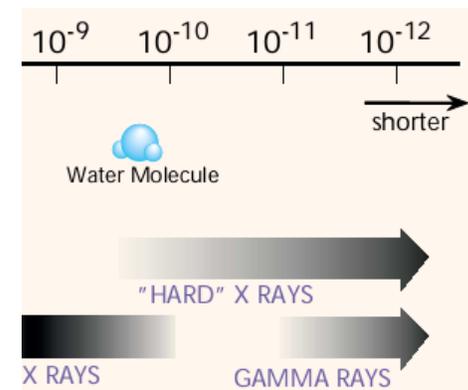
## Structure/microstructure (mm- $0.1\mu\text{m}$ )

Optical and electron microscopy, optical spectroscopies, ...



## Microstructure ( $\mu\text{m}$ -nm)

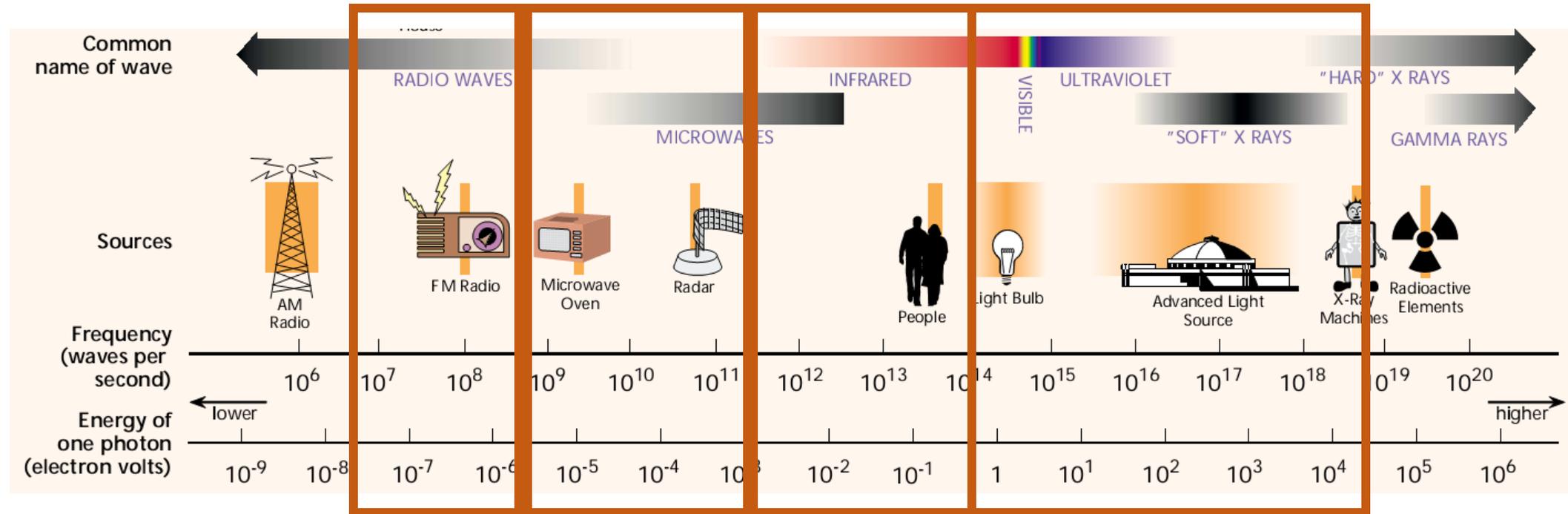
Electron microscopy, scanning probe microscopies (AFM, STM, ...), optical spectroscopies, small angle X-ray scattering (SAXS), ...



## Atomic structure (nm-fm)

High-resolution electron or scanning probe microscopy, X-ray/electron/neutron diffraction, ...

# Energetic intervals



**Nuclear spin transitions (NMR)**

**Molecular rotations**

**Molecular vibrations**

**Electronic transitions**  
Core levels and valence-conduction bands

# Some experimental techniques

## Diffraction

- X-rays
- Neutrons
- Electrons

## Microscopy

- Optical
- Electronic
- X-ray
- Scanning probe (STM, AFM)

## Spectroscopy

- Visible-IR-UV
- Raman
- Photoemission (X-ray or UV)
- X-ray absorption

And many more...

# Measurement parameters (technical criteria)

- **Precision:** Absence of casual errors. Closeness between obtained in different measurements.
- **Accuracy:** Absence of systematic errors. Closeness between measured values and real values.
- **Resolution:** Ability to discriminate between close values of a quantity.
- **Detection limit:** Minimum value of a quantity that is detectable with an experimental setup, for a set accuracy level.
- **Signal-to-noise ratio (SNR):** A measure of the interferences and of the intrinsic/extrinsic noise that characterizes the measurement.
- **Dynamic range:** Range of values of a quantity that is measurable with an instrument (with a proper calibration).
- **Selectivity:** Ability to discriminate different signal, or real signals from interferences.

# Elements of an experimental setup

## Signal generator – perturbation

- Particles (electrons, neutrons, ions), EM fields, applied forces, ...

## Sample – signal emission

- Radiation, particle emission, property change, ...

## Transducer + signal processor

- The signal is converted (e.g. thermocouple, piezoelectric, ...) and/or processed (amplified, filtered, integrated, ...)

## Reading device (output transducer)

- Depending on the type of signal, it is converted into a measurable quantity: photographic plate, CCD, photodiode, multimeter, ...

# Some other examples

Perturbation	Technique	Output signal
Electrons	Auger electron spectroscopy (AES), electron microscopy (SEM, TEM, ...), electron scattering (LEED, EELS, ...)	Electrons
Electrons	X-ray microanalysis (EDX, WDX), cathodoluminescence	Photons
Photons	X-ray photoemission spectroscopy (XPS) or ultraviolet photoemission spectroscopy (UPS)	Electrons
Photons	X-ray diffraction (XRD), X-ray fluorescence (XRF), UV-VIS-IR absorption spectroscopy, Raman spectroscopy, photoluminescence (PL)	Photons

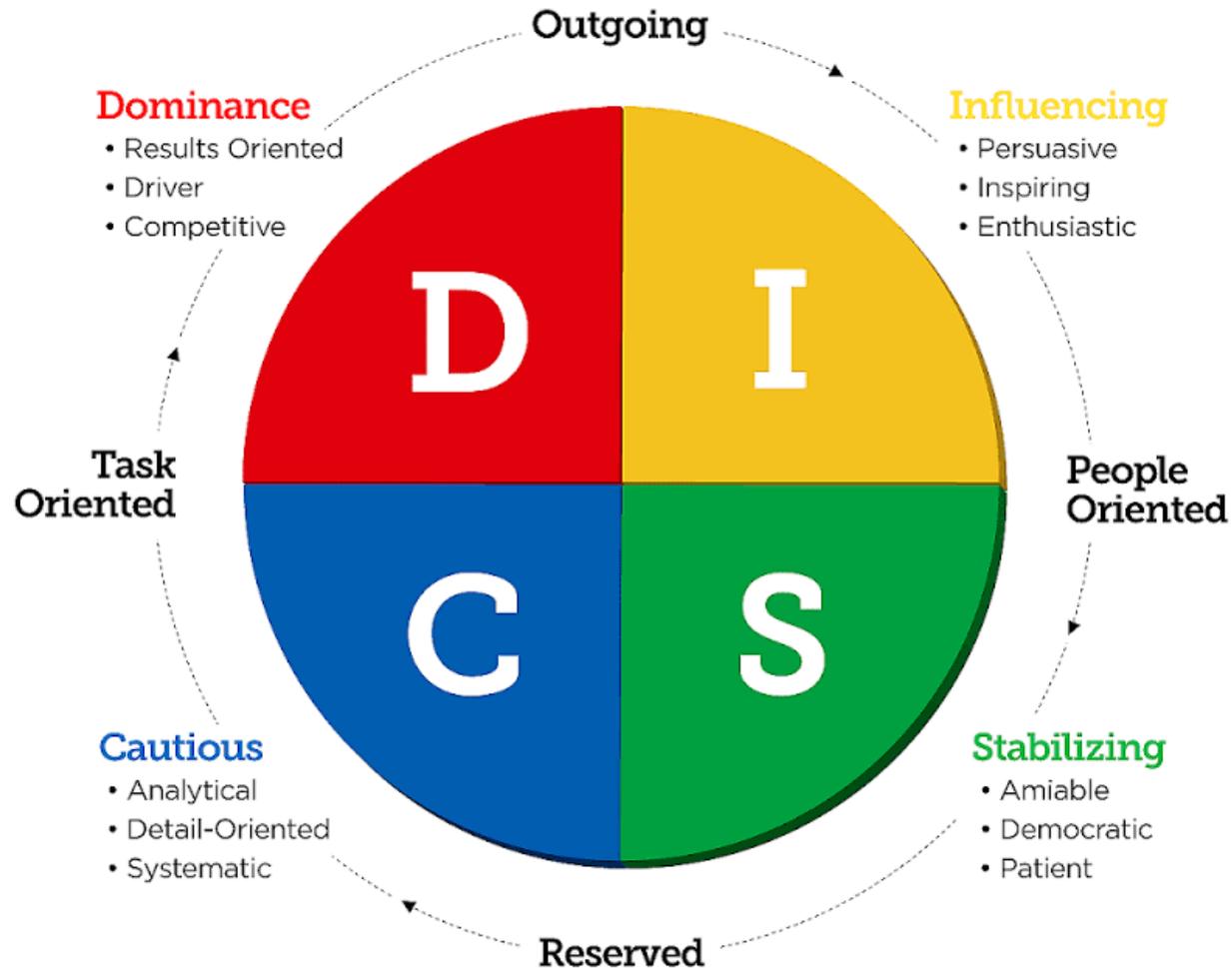
# What to do

- Divide in groups: ideally 3-4 groups, to work independently on the photoluminescence setup
- Planning: 72h in total, ~20h theory + ~52h practical

## Suggestions

- Compile a laboratory logbook, in which you report all details on the instruments and the measurement parameters.  
Something may be obvious in the moment you are measuring, but when it is time to write the report you might forget it...
- Make questions!

# The personality DISC



In each group, ideally:

1 red

1 yellow

1+ green and/or blue

# Timetable

	lunedì	martedì	mercoledì	giovedì	venerdì	
08:00						
08:15						
08:30		MACHINE LEARNING				
08:45						
09:00		MEDVET Eric Aula B [Edificio C7] 08:00 - 10:00				
09:15						
09:30		MECCANICA STATISTICA	FISICA DELLA MATERIA CONDENSATA I		FISICA DELLA MATERIA CONDENSATA I	
09:45						
10:00		IMPARATO ALBERTO Aula 5A [Edificio H2bis] 09:00 - 11:00	PERESSI MARIA Aula D [Edificio F] 09:00 - 11:00		PERESSI MARIA Aula D [Edificio F] 09:00 - 11:00	
10:15	LABORATORIO DI FISICA					
10:30	COMPUTAZIONALE -					
10:45	Lezione					
11:00	PERESSI MARIA, BECCA					
11:15	FEDERICO	LABORATORIO DI FISICA	INTERAZIONE		LABORATORIO DI FISICA	
11:30	Aula D [Edificio F] 10:00 - 12:00	DELLA MATERIA	RADIAZIONE-MATERIA E		COMPUTAZIONALE -	
11:45		CONDENSATA	LUCE DI SINCROTRONE		Lezione	
12:00						
12:15		SCAZZA FRANCESCO, MORGANTE ALBERTO, COSTANTINI ROBERTO, MARINELLI MATTEO	VESSELLI ERIK Laboratorio T20 [Edificio F] 11:00 - 13:00	COMPUTAZIONE QUANTISTICA	ATOMI, MOLECOLE E FOTONI	
12:30						
12:45						
13:00						
13:15	TEORIA DEI CAMPI I		MECCANICA STATISTICA	BASSI ANGELO Aula C [Edificio F] 12:00 - 14:00	SCAZZA FRANCESCO Aula B [Edificio F] 12:00 - 14:00	INTERAZIONE RADIAZIONE-MATERIA E LUCE DI SINCROTRONE
13:30						
13:45						
14:00	BASSI ANGELO Aula A [Edificio F] 13:00 - 15:00		IMPARATO ALBERTO Aula 3B [Edificio H2bis] 13:00 - 15:00		ATOMI, MOLECOLE E FOTONI	VESSELLI ERIK Aula 4A [Edificio H2bis] 13:00 - 15:00
14:15					LABORATORIO DI FISICA	
14:30					DELLA MATERIA	SCAZZA FRANCESCO Aula B [Edificio F] 13:00 - 16:00
14:45					CONDENSATA	
15:00						
15:15		TEORIA DEI CAMPI I	LABORATORIO DI FISICA	LABORATORIO DI FISICA	SCAZZA FRANCESCO, MORGANTE ALBERTO, COSTANTINI ROBERTO, MARINELLI MATTEO	
15:30			DELLA MATERIA	COMPUTAZIONALE -		
15:45			CONDENSATA	Laboratorio		
16:00		BASSI ANGELO Aula C [Edificio C7] 15:00 - 17:00	SCAZZA FRANCESCO, MORGANTE ALBERTO, COSTANTINI ROBERTO, MARINELLI MATTEO	PERESSI MARIA, BECCA FEDERICO Lab. informatico Poropat [Edificio F] 15:00 - 18:00		FISICA DELLA MATERIA CONDENSATA I
16:15	STRUMENTI INFORMATICI A					PERESSI MARIA
16:30						
16:45						
17:00	COSLOVICH DANIELE Aula A [Edificio F] 16:00 - 18:00	COMPUTAZIONE QUANTISTICA	Laboratorio di Fisica [Edificio C1] 15:00 - 18:00		MACHINE LEARNING	
17:15						
17:30					MEDVET Eric Aula C [Edificio C7] 16:00 - 19:00	
17:45						
18:00		BASSI ANGELO Aula C [Edificio F] 17:00 - 19:00				
18:15						
18:30						
18:45						
19:00						
19:15						
19:30						